

CLC5957

12-bit, 70MSPS Broadband Monolithic A/D Converter

General Description

The CLC5957 is a monolithic 12-bit, 70MSPS analog-to-digital converter. The device has been optimized for use in IF-sampled digital receivers and other applications where high resolution, high sampling rate, wide dynamic range, low power dissipation, and compact size are required. The CLC5957 features differential analog inputs, low jitter differential universal clock inputs, a low distortion track-and-hold with 0-300MHz input bandwidth, a band-gap voltage reference, data valid clock output, TTL compatible CMOS (3.3V or 2.5V) programmable output logic, and a proprietary 12-bit multi-stage quantizer. The CLC5957 is fabricated on the ABIC-V 0.8 micron BiCMOS process.

The CLC5957 features a 74dBc spurious free dynamic range (SFDR) and a 67dB signal to noise ratio (SNR). The wideband track-and-hold allows sampling of IF signals to greater than 250MHz. The part produces two-tone, dithered, SFDR of 83dBFS at 75MHz input frequency. The differential analog input provides excellent common mode rejection, while the differential universal clock inputs minimize jitter. The 48-pin TSSOP package provides an extremely small footprint for applications where space is a critical consideration. The CLC5957 operates from a single +5V power supply. Operation over the industrial temperature range of -40°C to +85°C is guaranteed. National Semiconductor tests each part to verify compliance with the guaranteed specifications.

Features

- 70MSPS
- Wide dynamic range
SFDR: 74dBc
SFDR w/dither: 85dBFS
SNR: 67dB
- IF sampling capability
- Input bandwidth = 0-300MHz
- Low power dissipation: 640mW
- Very small package: 48-pin TSSOP
- Single +5V supply
- Data valid clock output
- Programmable output levels:
3.3V or 2.5V

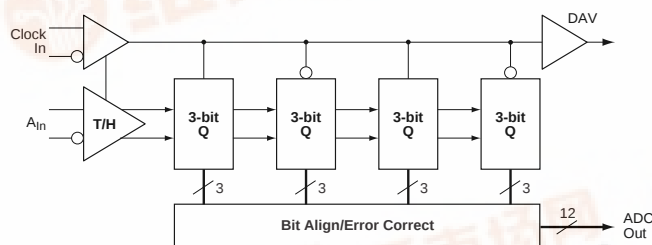
Applications

- Cellular base-stations
- Digital communications
- Infrared/CCD imaging
- IF sampling
- Electro-optics
- Instrumentation
- Medical imaging
- High definition video

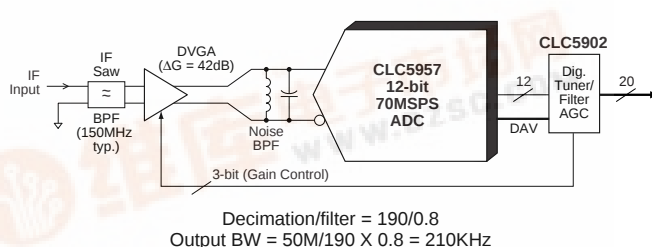


Actual Size

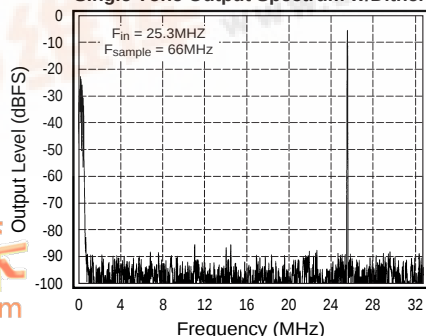
ADC Block Diagram



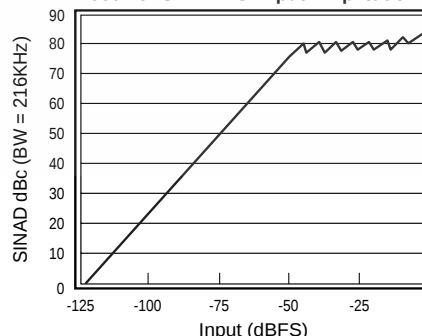
First IF Receiver



Single Tone Output Spectrum w/Dither



Receiver SINAD vs. Input Amplitude



CLC5957 Electrical Characteristics (V_{cc}= +5V, 66MSPS; unless specified) (T_{min} = -40°C, T_{max} = +85°C)

PARAMETERS	CONDITIONS	TEMP	RATINGS			UNITS	NOTES
			MIN	TYP	MAX		
RESOLUTION		Full		12		Bits	1
DIFF. INPUT VOLTAGE RANGE		Full		2.048		V	
MAXIMUM CONVERSION RATE		Full	70	75		MSPS	1
SNR	f _{in} = 25MHz, A _{in} = -1dBFS	+25°C	63	66		dBFS	1
SFDR	f _{in} = 25MHz, A _{in} = -1dBFS	+25°C	66	74		dBc	1
NO MISSING CODES	f _{in} = 5MHz, A _{in} = -1dBFS	+25°C	Guaranteed				1
DYNAMIC PERFORMANCE							
large-signal bandwidth	A _{in} = -3dBFS	+25°C		300		MHz	
overvoltage recovery time	A _{in} = 1.5FS (0.01%)	+25°C		12		ns	
effective aperture delay (Ta)		+25°C		-0.41		ns	
aperture jitter		+25°C		0.3		ps(rms)	
NOISE AND DISTORTION							
signal-to-noise ratio (w/o 50 harmonics)							
f _{in} = 5.0MHz	A _{in} = -1dBFS	Full	60	67		dBFS	1
f _{in} = 25MHz	A _{in} = -1dBFS	Full		66		dBFS	
f _{in} = 75MHz	A _{in} = -3dBFS	Full		65		dBFS	
f _{in} = 150MHz	A _{in} = -15dBFS	Full		66		dBFS	
f _{in} = 250MHz	A _{in} = -15dBFS	Full		66		dBFS	
spurious-free dynamic range							
f _{in} = 5.0MHz	A _{in} = -1dBFS	Full	60	74		dBc	1
f _{in} = 25MHz	A _{in} = -1dBFS	Full		74		dBc	
f _{in} = 75MHz	A _{in} = -3dBFS	Full		72		dBc	
f _{in} = 150MHz	A _{in} = -15dBFS	Full		69		dBc	
f _{in} = 250MHz	A _{in} = -15dBFS	Full		65		dBc	
intermodulation distortion							
f _{in1} = 149.84MHz, f _{in2} = 149.7MHz	A _{in} = -10dBFS	+25°C		68		dBFS	
f _{in1} = 249.86MHz, f _{in2} = 249.69MHz	A _{in} = -10dBFS	+25°C		58		dBFS	
dithered performance							
spurious-free dynamic range							
f _{in} = 19MHz	A _{in} = -6dBFS	+25°C		85		dBFS	
intermodulation distortion							
f _{in1} = 74MHz, f _{in2} = 75MHz	A _{in} = -12dBFS	+25°C		83		dBFS	
DC ACCURACY AND PERFORMANCE							
differential non-linearity	f _{in} = 5MHz, A _{in} = -1dBFS	Full		±0.65		LSB	
integral non-linearity	f _{in} = 5MHz, A _{in} = -1dBFS	Full		±1.5		LSB	
no missing codes	f _{in} = 5MHz, A _{in} = -1dBFS	Full	Guaranteed				1
offset error		Full	-30	0	30	mV	1
gain error		Full		1.2		%FS	
V _{ref}		Full	2.2	2.37	2.6	V	1
ANALOG INPUTS							
analog differential input voltage range		Full		2.048		V _{pp}	
analog input resistance (single ended)		Full		500		Ω	
analog input resistance (differential)		Full		1000		Ω	
analog input capacitance (single-ended)		Full		2		pF	
ENCODE INPUTS (Universal)							
V _{IH}		+25°C			5	V	3
V _{IL}		+25°C	0			V	3
differential input swing		+25°C	0.2			V	3
DIGITAL OUTPUTS							
output voltage	logic LOW	+25°C		0.01	0.4	V	1
OUTLEV = 1 (open)	logic HIGH	+25°C	3.2	3.5	3.8	V	1
OUTLEV = 0 (GND)	logic HIGH	+25°C	2.4	2.7	3.0	V	1
TIMING (C load < 7pF)							
maximum conversion rate		Full	70	75		MSPS	1
minimum conversion rate		+25°C		10		MSPS	
pulse width high		Full		7.2		ns	
pulse width low		Full		7.2		ns	
pipeline latency		Full			3.0	clk cycle	
falling ENCODE to output change (50%) (T _{od})		+25°C		10		ns	
rising ENCODE to DAV change (50%) (T _{dv})		+25°C		9.6		ns	

CLC5957 Electrical Characteristics ($V_{CC} = +5V$, 66MSPS; unless specified) ($T_{min} = -40^{\circ}C$, $T_{max} = +85^{\circ}C$)

PARAMETERS	CONDITIONS	TEMP	RATINGS			UNITS	NOTES
			MIN	TYP	MAX		2
POWER REQUIREMENTS							
+5V supply current		Full		128	150	mA	1
Power dissipation		Full		640	750	mW	1
V _{CC} power supply rejection ratio		+25°C		64		dB	

Min/max ratings are based on product characterization and simulation. Individual parameters are tested as noted. Outgoing quality levels are determined from tested parameters.

Notes

- 1) These parameters are 100% tested at 25°C. Sample tested at full temperature range.
- 2) Typical specifications are based on the mean test values of deliverable converters from the first three diffusion lots.
- 3) See page 7, Figure 3 for ENCODE Inputs circuit.

Absolute Maximum Ratings

positive supply voltage (V_{CC})	-0.5V to +6V
differential voltage between any two grounds	<100mV
analog input voltage range	GND to V_{CC}
digital input voltage range	-0.5V to + V_{CC}
output short circuit duration (one-pin to ground)	infinite
junction temperature	175°C
storage temperature range	-65°C to 150°C
lead solder duration (+300°C)	10sec

Note: Absolute maximum ratings are limiting values, to be applied individually, and beyond which the serviceability of the circuit may be impaired. Functional operability under any of these conditions is not necessarily implied. Exposure to maximum ratings for extended periods may affect device reliability.

Recommended Operating Conditions

positive supply voltage (V_{CC})	+5V $\pm 5\%$
analog input voltage range	2.048V _{pp} diff.
operating temperature range	-40°C to +85°C

Package Thermal Resistance

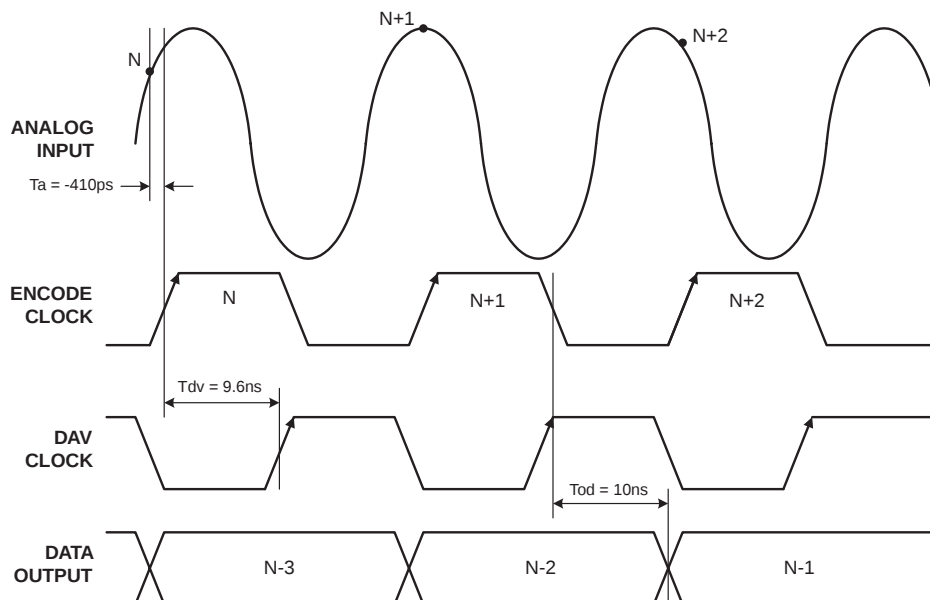
Package	θ_{JA}	θ_{JC}
48-pin TSSOP	56°C/W	16°C/W

Reliability Information

Transistor count	5000
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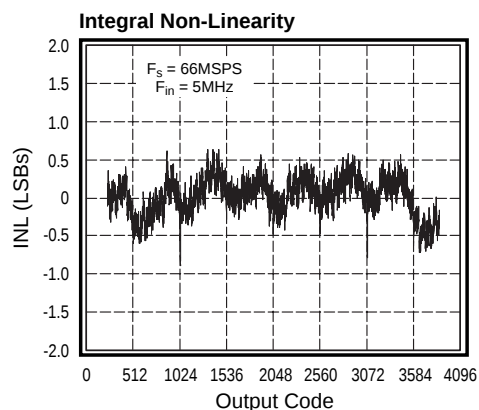
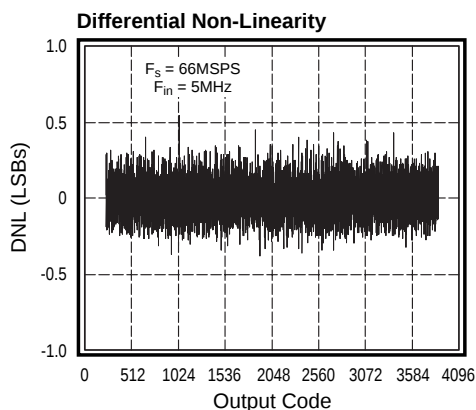
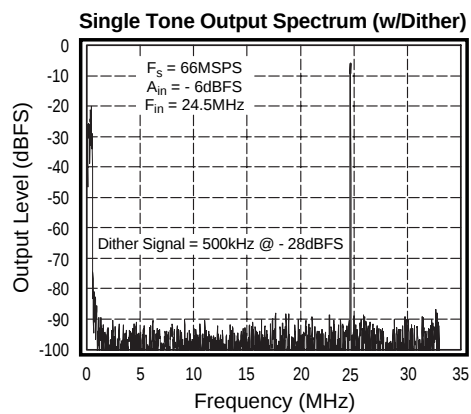
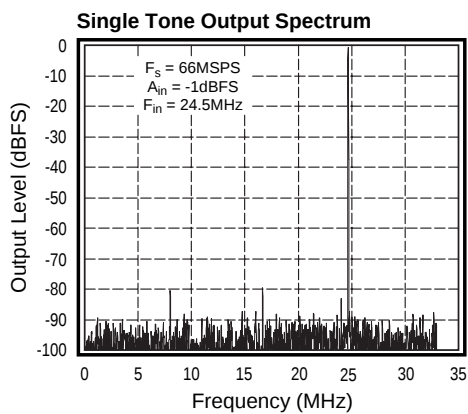
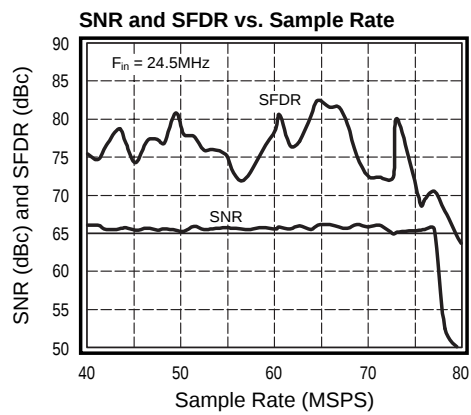
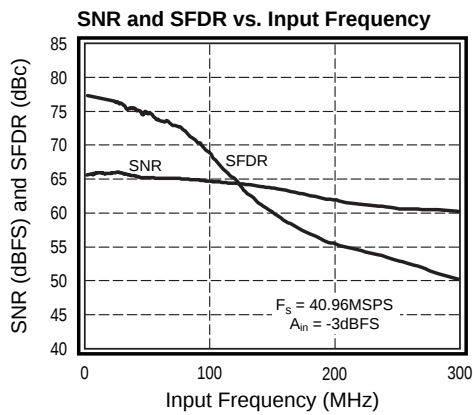
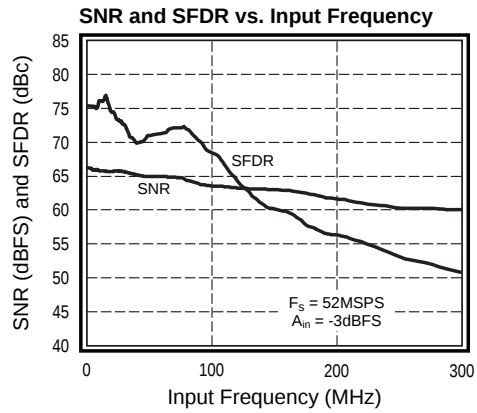
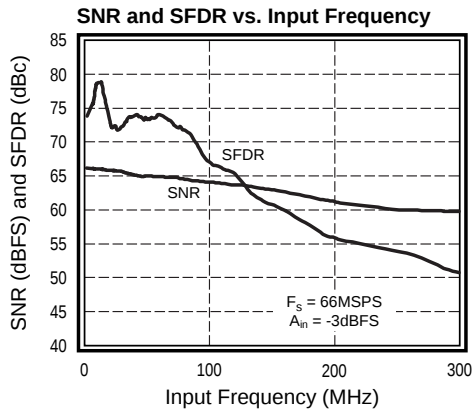
Ordering Information

Model	Temperature Range	Description
CLC5957MTD CLC5957PCASM	-40°C to +85°C	48-pin TSSOP Fully loaded evaluation board with CLC5957 ... ready for test.

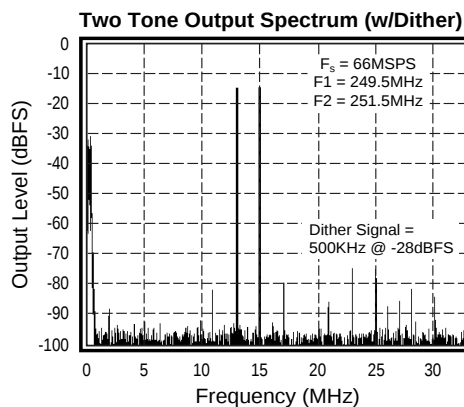
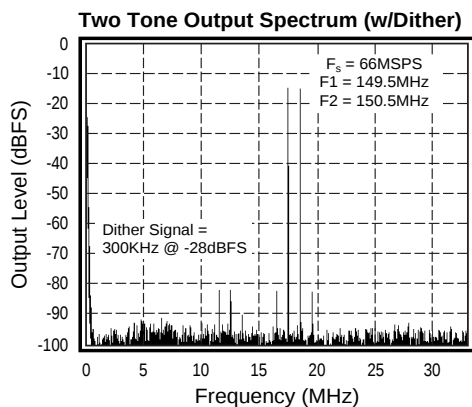
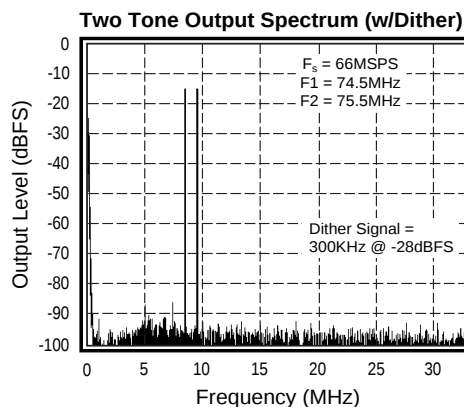
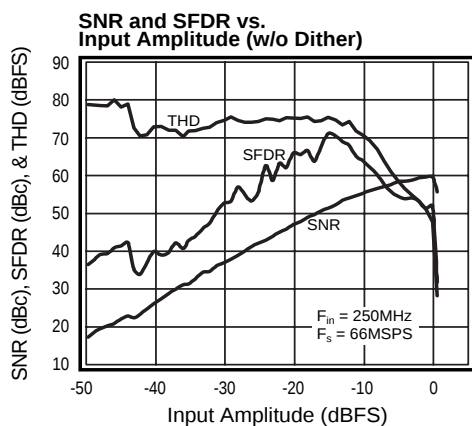
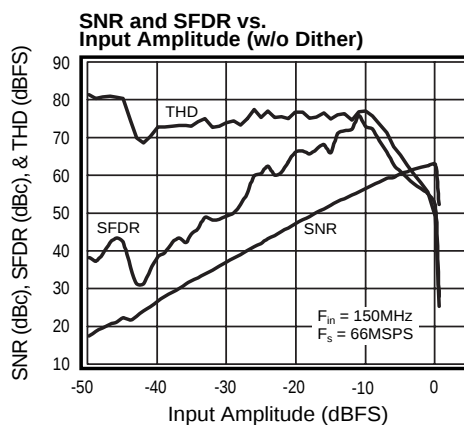
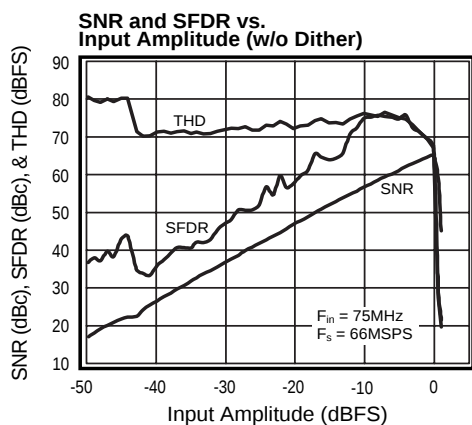
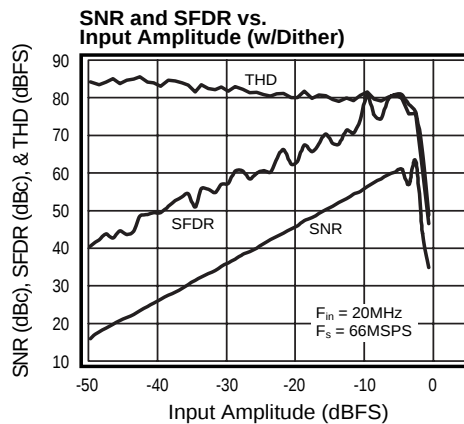
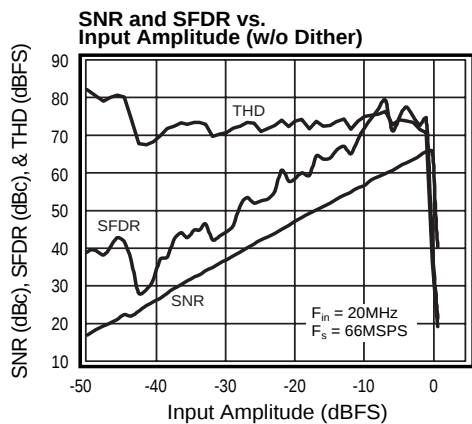


CLC5957 Timing Diagram

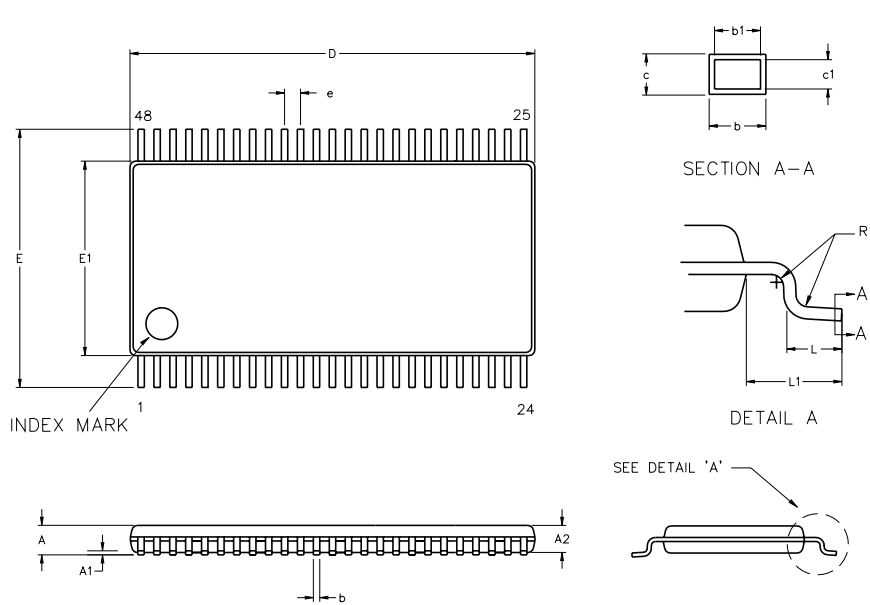
CLC5957 Typical Performance Characteristics ($V_{CC} = +5V$)



CLC5957 Typical Performance Characteristics ($V_{CC} = +5V$)



Physical Dimensions

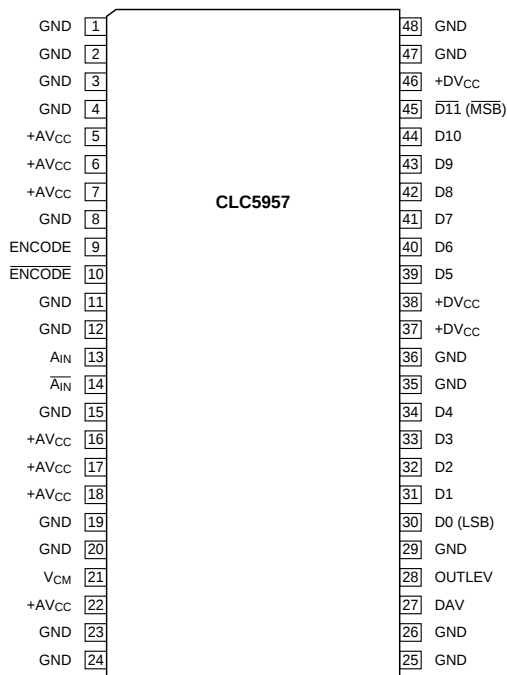


Symbol	Min	Max	Notes
A	—	1.10	
A1	0.05	0.15	
A2	0.80	1.05	
b	0.17	0.27	
b1	0.17	0.23	
c	0.09	0.20	
c1	0.09	0.16	
D	12.40	12.60	2
E	8.1 BSC		
E1	6.00	6.20	2
e	0.50 BSC		
L	0.50	0.75	
L1	1.00 REF		
R1	0.127		

Notes:

1. All dimensions are in millimeters.
2. Dimensions D and E1 do not include mold protrusion. Allowable protrusion is 0.20mm per side.

CLC5957 Pin Definitions



$A_{IN}, \overline{A_{IN}}$

(Pin 13, 14) Differential input with a common mode voltage of +2.4V. The ADC full scale input is $1.024V_{pp}$ on each of the complimentary input signals.

**ENCODE,
ENCODE**

(Pin 9, 10) Differential clock where ENCODE initiates a new data conversion cycle on each rising edge. Logic for these inputs are 50% duty cycle universal differential signal (>200mV). The clock input is internally biased to $V_{CC}/2$ with a termination impedance of 2.5k Ω .

D0-D11

(Pins 30-34, 39-45) Digital data outputs are CMOS and TTL compatible. D0 is the LSB and $\overline{D11}$ is the MSB. MSB is inverted. Output coding is two's complement.

DAV

(Pin 27) Data Valid Clock. Data is valid on rising edge.

OUTLEV

(Pin 28) Output Logic 3.3V or 2.5V option.
Open = 3.3V, GND = 2.5V.

V_{CM}

(Pin 21) Internal common mode voltage reference. Nominally +2.4V. Can be used for the input common mode voltage. This voltage is derived from an internal bandgap reference.

GND

(Pins 1-4, 8, 11, 12, 15, 19, 20, 23-26, 29, 35, 36, 47, 48) circuit ground.

+AV_{CC}

(Pins 5-7, 16-18, 22,) +5V power supply for the analog section. Bypass to ground with a 0.1 μ F capacitor.

+DV_{CC}

(Pin 37, 38, 46) +5V power supply for the digital section. Bypass to ground with a 0.1 μ F capacitor.

CLC5957 Applications

Analog Inputs and Bias

Figure 1 depicts the analog input and bias scheme. Each of the differential analog inputs are internally biased to a nominal voltage of 2.40 volts DC through a 500Ω resistor to a low impedance buffer. This enables a simple interface to a broadband RF transformer with a center-tapped output winding that is decoupled to the analog ground. If the application requires the inputs to be DC coupled, the V_{cm} output can be used to establish the proper common-mode input voltage for the ADC. The V_{cm} voltage reference is generated from an internal bandgap source that is very accurate and stable.

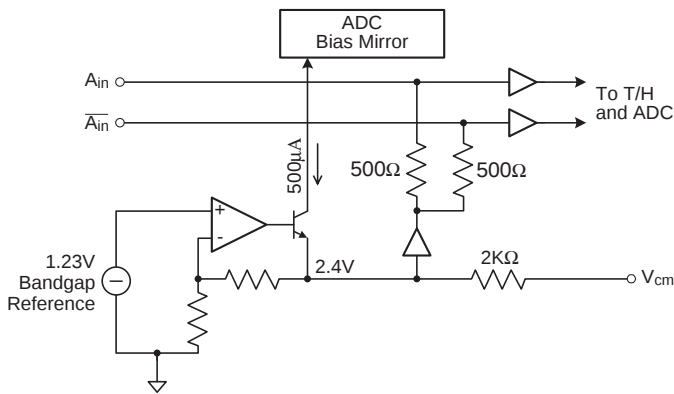


Figure 1: CLC5957 Bias Scheme

The V_{cm} output may also be used to power down the ADC. When the V_{cm} pin is pulled above 3.5V, the internal bias mirror is disabled and the total current is reduced to less than 10mA. Figure 2 depicts how this function can be used. The diode is necessary to prevent the logic gate from altering the ADC bias value.

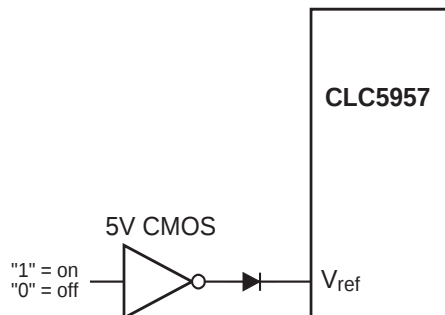


Figure 2: Power Shutdown Scheme

ENCODE Clock Inputs

The CLC5957's differential input clock scheme is compatible with all commonly used clock sources. Although small differential and single-ended signals are adequate, for best aperture jitter performance a low noise differential clock with a high slew rate is preferred. As depicted in Figure 3, both ENCODE clock inputs are internally biased to $V_{CC}/2$ through a pair of 5KΩ resistors. The clock input buffer operates with any common-mode voltage between the supply and ground.

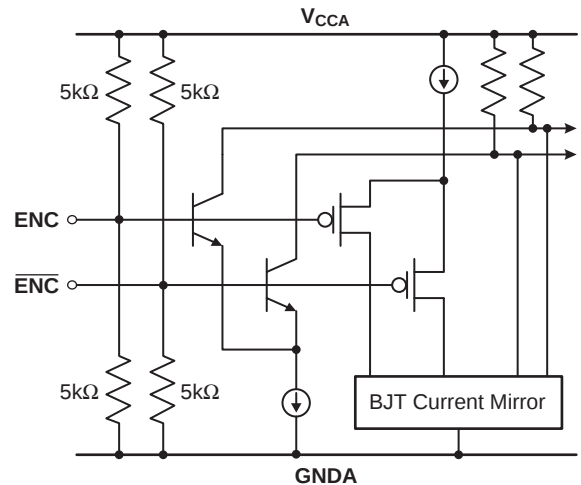


Figure 3: CLC5957 ENCODE Clock Inputs

The internal bias resistors simplify the clock interface to another center-tapped transformer as depicted in Figure 4. A low phase noise, RF synthesizer of moderate amplitude (1 - 4V_{pp}) can drive the ADC through this interface.

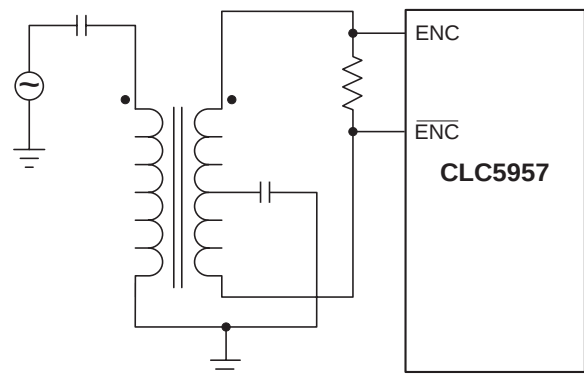


Figure 4: Transfer Coupled Clock Scheme

Figures 5 and 6 show the clock interface schemes to several other types of clock sources.

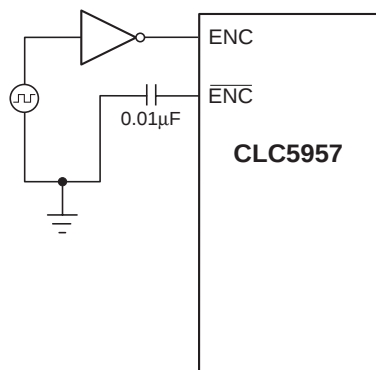


Figure 5: 5V CMOS Level Clock Scheme

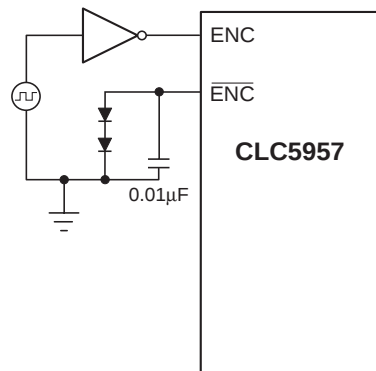


Figure 6: TTL or 3V CMOS Level Clock Scheme

Digital Outputs and Level Select

Figure 7 depicts the digital output buffer and bias used in the CLC5957. Although each of the twelve output bits uses a controlled current buffer to limit supply transients, it is recommended that parasitic loading of the outputs is minimized. Because these output transients are harmonically related to the analog input signal, excessive loading will degrade ADC performance at some frequencies.

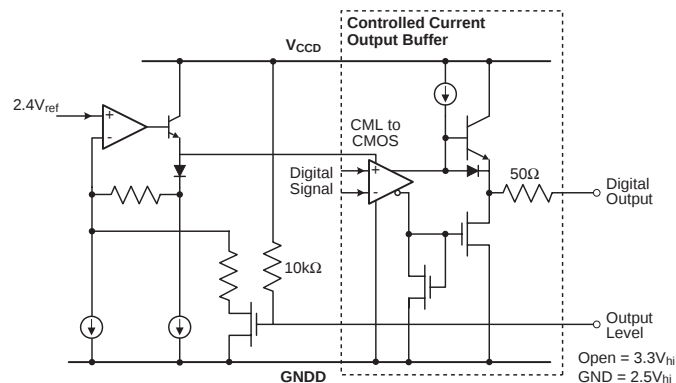


Figure 7: CLC5957 Digital Outputs

The logic high level is slaved to the internal 2.4 voltage reference. The OUTLEV control pin selects either a 3.3V or 2.5V logic high level. An internal pullup resistor selects the 3.3 volt level as the default when the OUTLEV pin is left open. Grounding the OUTLEV pin selects the 2.5V logic high level.

To ease user interface to subsequent digital circuitry, the CLC5957 has a data valid clock output (DAV). In order to match delays over IC processing variables, this digital output also uses the same output buffer as the data bits. The DAV clock output is simply a delayed version of the ENCODE input clock. Since the ADC output data change is slaved to the falling edge of the ENCODE clock, the rising DAV clock edge occurs near the center of the data valid window (or eye) regardless of the sampling frequency.

CLC5957 Evaluation Board

Description

The Evaluation board for the CLC5957 allows for easy test and evaluation of the product. The part may be ordered with all components loaded and tested. The order number is the CLC5957PCASM. The user supplies an analog input signal, encode signal and power to the board and is able to take latched 12-bit digital data out of the board.

ENCODE Input (ENC)

The ENCODE input is an SMA connector with a termination of 50Ω . The encode signal is converted to an AC coupled, differential clock signal centered between V_{CC} and ground. The user should supply a sinusoidal or square wave signal of $>200mV_{pp}$ and $<4V_{pp}$ with a 50% duty cycle. The duty cycle can vary from 50% if the minimum clock pulse width times are observed. A low jitter source will be required for IF-sampled analog input signals to maintain best performance.

CLC5957 Clock Option

The CLC5957 evaluation board is configured for use with an optional crystal clock oscillator source. The component Y1 may be loaded with a "Full-sized", HCMOS type, crystal oscillator.

Analog Input (AIN)

The analog input is an SMA connector with a 50Ω termination. The signal is converted from single to differential by a transformer with a 5 to 260MHz bandwidth and approximately one dB loss. Full scale is approximately 11dBm or $2.2V_{pp}$. It is recommended that the source for the analog input signal be low jitter, low noise and low distortion to allow for proper test and evaluation of the CLC5957.

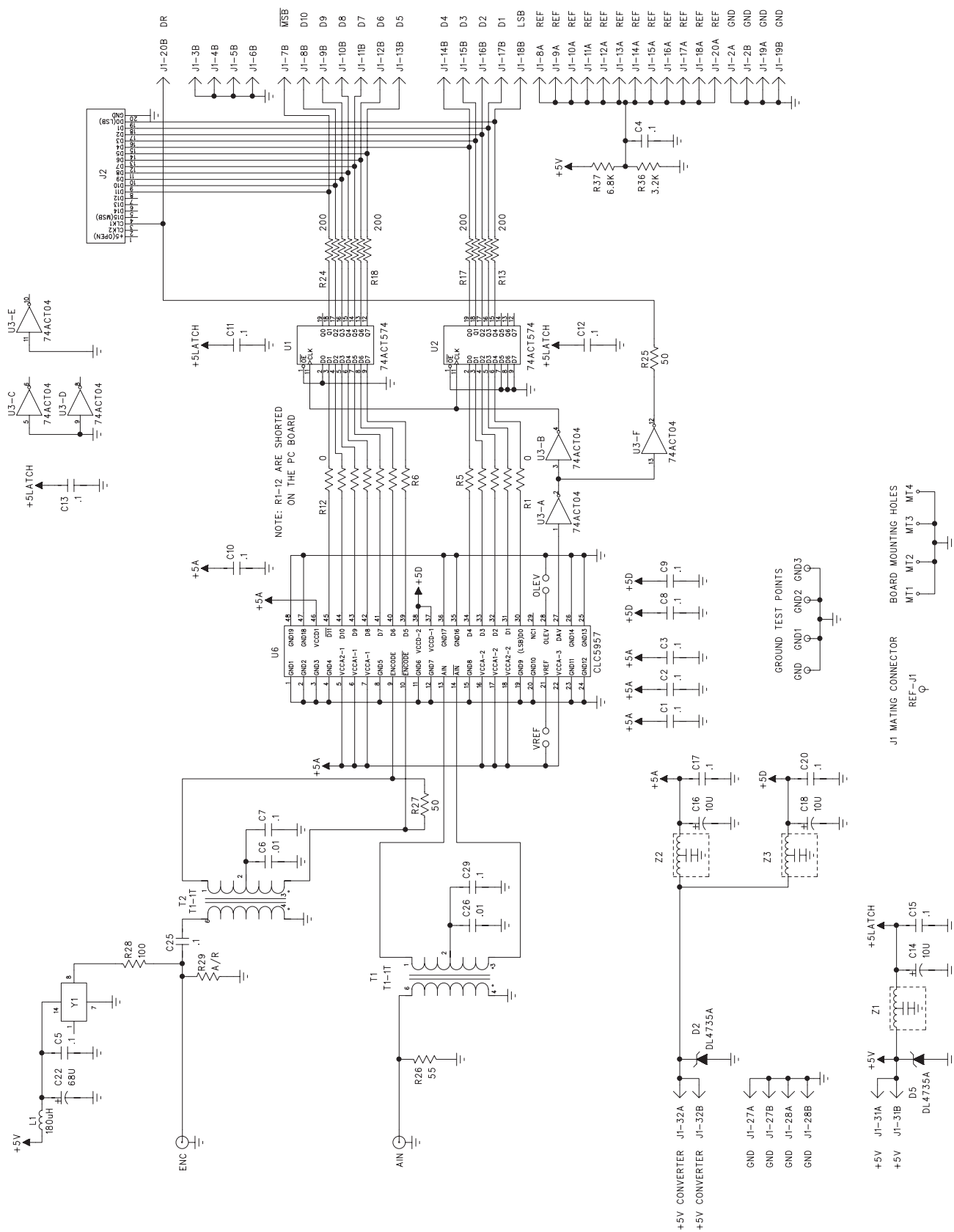
Supply Voltages (J1 pins 31 A&B and 32 A&B)

The CLC5957PCASM is powered from a single 5V supply connected from the referenced pins on the Euro-card connector. The recommended supplies are low noise linear supplies.

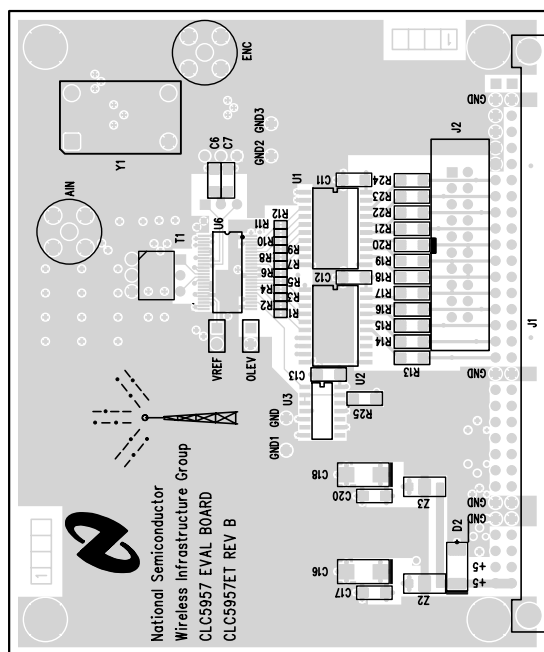
Digital Outputs (J1 pins 7B ($\overline{MSB}$, $\overline{D11}$) through 18B (LSB) and 20B (Data Valid))

The digital outputs are provided on the Eurocard connector. The outputs are buffered by 5V CMOS latches with 50Ω series output resistors. The rising edge of Data Valid may be used to clock the output data into data collection cards or logic analyzers. The board has a location for the HP 01650-63203 termination adapter for HP 16500 logic analyzers to simplify connection to the analyzer.

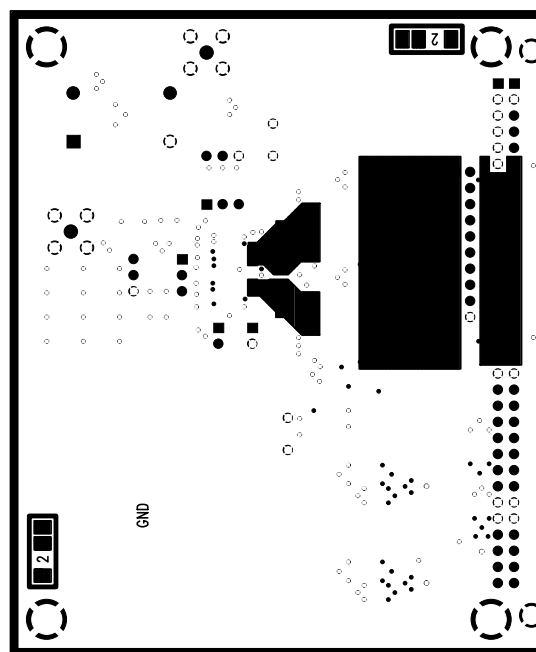
CLC5957 Evaluation Board Schematic



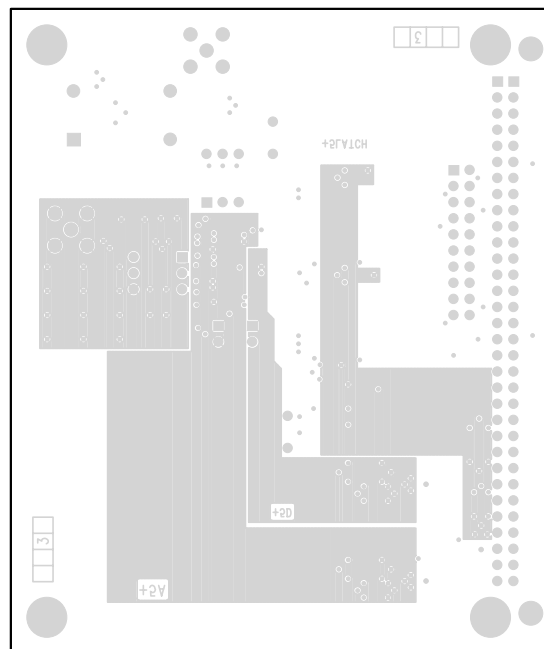
CLC5957 Evaluation Board Layout



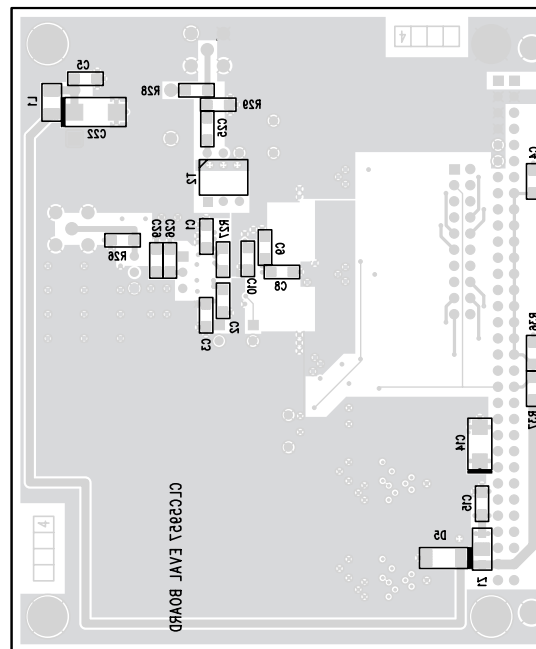
CLC5957PCASM Layer 1



CLC5957PCASM Layer 2



CLC5957PCASM Layer 3



CLC5957PCASM Layer 4

CLC5957 12-bit, 70MSPS Broadband Monolithic A/D Converter

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.



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